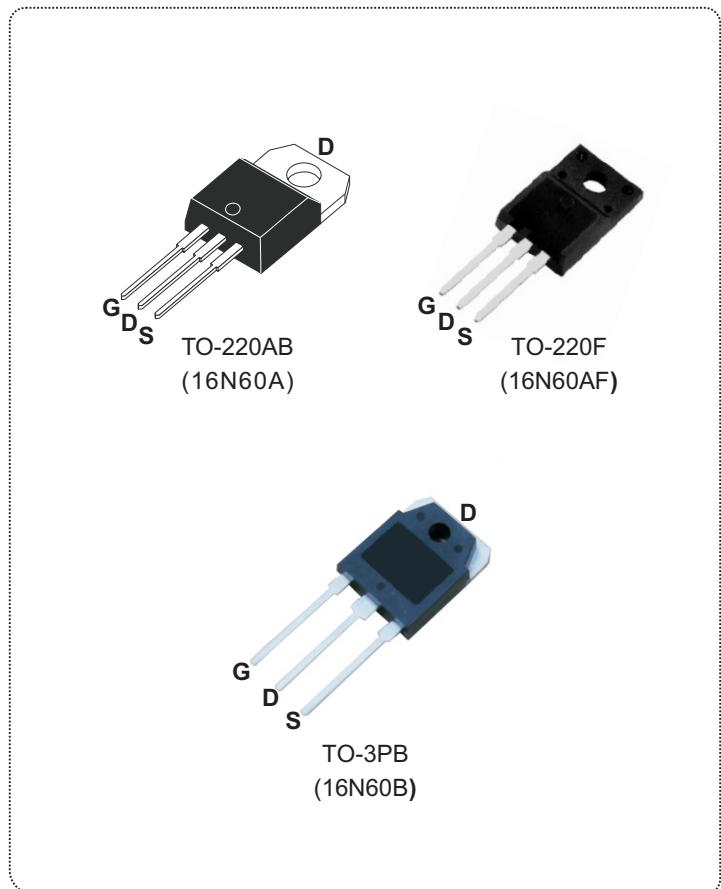


N-Channel Power MOSFET (16A, 600Volts)

DESCRIPTION

The Nell **16N60** is a three-terminal silicon device with current conduction capability of 16A, fast switching speed, low on-state resistance, breakdown voltage rating of 600V ,and max. threshold voltage of 4 volts.

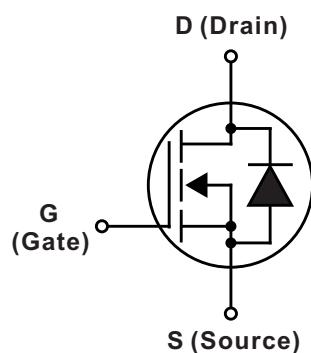
They are designed for use in applications such as switched mode power supplies, DC to DC converters, PWM motor controls, server/telecom power, FPD TV power, ATX power, and industrial power applications.



FEATURES

- $R_{DS(ON)} = 0.17\Omega @ V_{GS} = 10V$
- Ultra low gate charge(52.3nC max.)
- Low reverse transfer capacitance ($C_{RSS} = 5pF$ typical)
- Fast switching capability
- 100% avalanche energy specified
- Improved dv/dt capability
- 150°C operation temperature

| PRODUCT SUMMARY | |
|---------------------------|-----------------------|
| I_D (A) | 16 |
| V_{DSS} (V) | 600 |
| $R_{DS(ON)}$ (Ω) | 0.17 @ $V_{GS} = 10V$ |
| $Q_G(nC)$ max. | 52.3 |



| ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ unless otherwise specified) | | | | | |
|---|---|---|-----------------|------------|---------------------------|
| SYMBOL | PARAMETER | TEST CONDITIONS | | VALUE | UNIT |
| V_{DSS} | Drain to Source voltage | $T_J=25^\circ\text{C}$ to 150°C | | 600 | V |
| V_{DGR} | Drain to Gate voltage | $R_{GS}=20\text{K}\Omega$ | | 600 | |
| V_{GS} | Gate to Source voltage | | | ± 30 | |
| I_D | Continuous Drain Current | $T_C=25^\circ\text{C}$ | | 16 | A |
| | | $T_C=100^\circ\text{C}$ | | 10.1 | |
| I_{DM} | Pulsed Drain current(Note 1) | | | 48 | |
| I_{AR} | Avalanche current(Note 1) | | | 5.3 | |
| E_{AR} | Repetitive avalanche energy(Note 1) | $I_{AR}=16\text{A}$, $R_{GS}=50\Omega$, $V_{GS}=10\text{V}$ | | 1.34 | mJ |
| E_{AS} | Single pulse avalanche energy(Note 2) | $I_{AS}=5.3\text{A}$, $L=7.1\text{mH}$ | | 355 | |
| dv/dt | MOSFET dv/dt ruggedness(Note 3) | | | 100 | V/ns |
| | Peak diode recovery dv/dt (Note 3) | | | 20 | |
| P_D | Total power dissipation | $T_C=25^\circ\text{C}$ | TO-220AB/TO-3PB | 134.4 | W |
| | | | TO-220F | 35.7 | |
| T_J | Derate above 25°C | $T_C=25^\circ\text{C}$ | TO-220AB/TO-3PB | 1.08 | $^\circ\text{C}/\text{W}$ |
| | | | TO-220F | 0.29 | |
| T_J | Operation junction temperature | | | -55 to 150 | |
| T_{STG} | Storage temperature | | | -55 to 150 | |
| T_L | Maximum soldering temperature, for 10 seconds | 1.6mm from case | | 300 | $^\circ\text{C}$ |
| | Mounting torque, #6-32 or M3 screw | | | 10 (1.1) | |
| | | | | | Ibf-in (N·m) |

Note: 1.Repetitive rating: pulse width limited by junction temperature..

2. $I_{AS} = 5.3\text{A}$, $V_{DD} = 50\text{V}$, $R_{GS} = 25\Omega$, starting $T_J=25^\circ\text{C}$.

3. $I_{SD} \leq 16\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} = 380\text{V}$, starting $T_J=25^\circ\text{C}$.

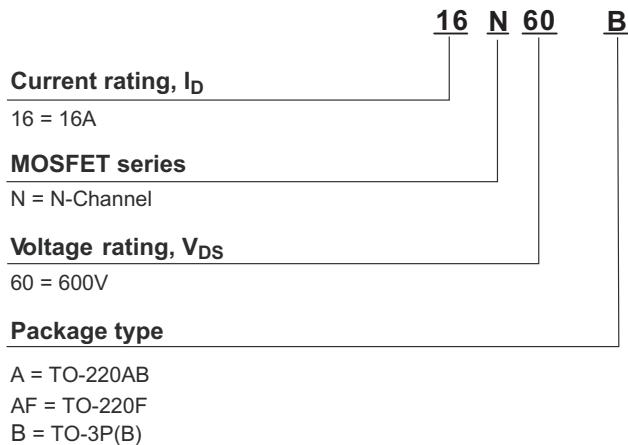
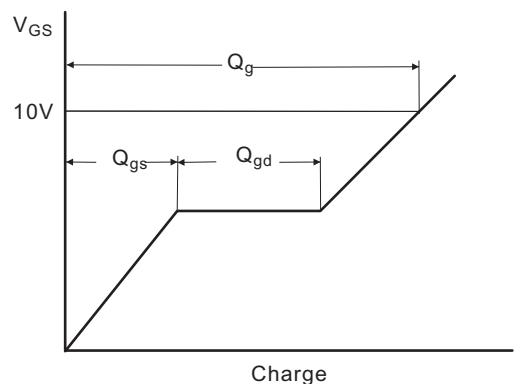
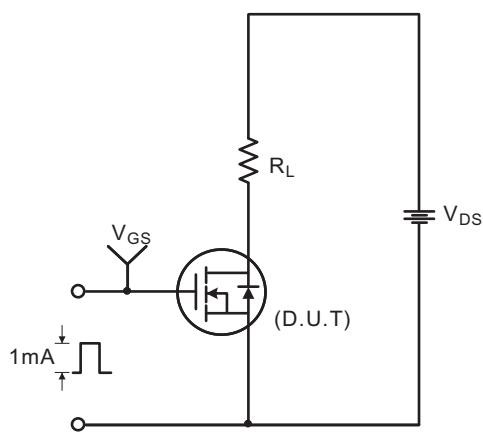
| THERMAL RESISTANCE | | | | | | |
|--------------------|---|------------------|------|------|------|---------------------------|
| SYMBOL | PARAMETER | | Min. | Typ. | Max. | UNIT |
| $R_{th(j-c)}$ | Thermal resistance, junction to case | TO-220AB/TO-3PB | | | 0.93 | $^\circ\text{C}/\text{W}$ |
| | | TO-220F | | | 3.5 | |
| $R_{th(c-s)}$ | Thermal resistance, case to heatsink | TO-3PB | | 0.24 | | |
| | | TO-220AB/TO-220F | | 0.5 | | |
| $R_{th(j-a)}$ | Thermal resistance, junction to ambient | TO-3PB | | | 40 | |
| | | TO-220AB/TO220F | | | 62.5 | |

| ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified) | | | | | | | |
|---|--|---|---------------------------|------|------|-------|---------------------------|
| SYMBOL | PARAMETER | TEST CONDITIONS | | Min. | Typ. | Max. | UNIT |
| © OFF CHARACTERISTICS | | | | | | | |
| $V_{(\text{BR})\text{DSS}}$ | Drain to source breakdown voltage | $I_D = 1\text{mA}, V_{GS} = 0\text{V}$ | | 600 | | | V |
| $\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$ | Breakdown voltage temperature coefficient | $I_D = 1\text{mA}, V_{DS} = V_{GS}$ | | | 0.73 | | $\text{V}/^\circ\text{C}$ |
| I_{DSS} | Drain to source leakage current | $V_{DS} = 600\text{V}, V_{GS} = 0\text{V}$ | $T_C = 25^\circ\text{C}$ | | | 10 | μA |
| | | $V_{DS} = 480\text{V}, V_{GS} = 0\text{V}$ | $T_C = 125^\circ\text{C}$ | | | 100 | |
| I_{GSS} | Gate to source forward leakage current | $V_{GS} = 30\text{V}, V_{DS} = 0\text{V}$ | | | | 100 | nA |
| | Gate to source reverse leakage current | $V_{GS} = -30\text{V}, V_{DS} = 0\text{V}$ | | | | -100 | |
| © ON CHARACTERISTICS | | | | | | | |
| $R_{\text{DS(ON)}}$ | Static drain to source on-state resistance | $V_{GS} = 10\text{V}, I_D = 8\text{A}$ | | | 0.17 | 0.199 | Ω |
| $V_{\text{GS(TH)}}$ | Gate threshold voltage | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ | | 2 | | 4 | V |
| g_{fs} | Forward transconductance | $V_{DS} = 40\text{V}$ | TO-3PB | | 20 | | S |
| | | $I_D = 8\text{A}$ | TO-220AB/TO-220F | | 13 | | |
| © DYNAMIC CHARACTERISTICS | | | | | | | |
| C_{iss} | Input capacitance | $V_{DS} = 100\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | | | 1630 | 2170 | pF |
| C_{oss} | Output capacitance | | | | 70 | 95 | |
| C_{rss} | Reverse transfer capacitance | | | | 5 | 10 | |
| C_{oss} | Output capacitance | | | | 40 | 60 | |
| $C_{\text{oss,eff.}}$ | Effective output capacitance | $V_{DS} = 0 \text{ to } 480\text{V}, V_{GS} = 0\text{V}$ | | | 176 | | |
| © SWITCHING CHARACTERISTICS | | | | | | | |
| $t_{\text{d(ON)}}$ | Turn-on delay time | $V_{DD} = 380\text{V}, V_{GS} = 10\text{V}$ $I_D = 8\text{A}, R_{GS} = 4.7\Omega$ (Note 1,2) | | | 15.8 | 41.6 | ns |
| t_r | Rise time | | | | 15.5 | 41 | |
| $t_{\text{d(OFF)}}$ | Turn-off delay time | | | | 60.3 | 130.6 | |
| t_f | Fall time | | | | 20.2 | 50.4 | |
| Q_G | Total gate charge | $V_{DD} = 380\text{V}, V_{GS} = 10\text{V}$ $I_D = 8\text{A}$, (Note 1,2) | | | 40.2 | 52.3 | nC |
| Q_{GS} | Gate to source charge | | | | 6.7 | | |
| Q_{GD} | Gate to drain charge (Miller charge) | | | | 12.9 | | |
| ESR | Equivalent series resistance (G-S) | Drain open | | | 2.9 | | Ω |

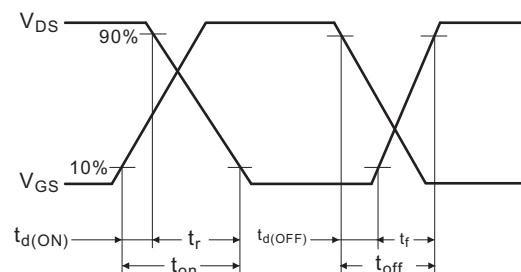
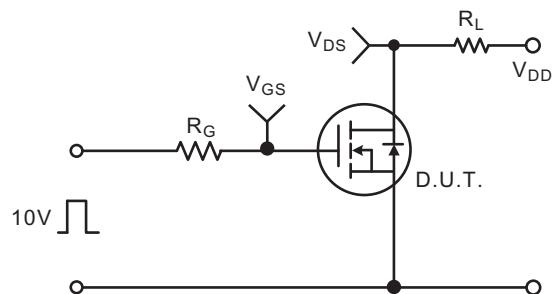
| SOURCE TO DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified) | | | | | | |
|--|------------------------------------|---|------|------|------|---------------|
| SYMBOL | PARAMETER | TEST CONDITIONS | Min. | Typ. | Max. | UNIT |
| V_{SD} | Diode forward voltage | $I_{SD} = 8\text{A}, V_{GS} = 0\text{V}$ | | | 1.2 | V |
| $I_s (I_{SD})$ | Continuous source to drain current | Integral reverse P-N junction diode in the MOSFET | | | 16 | |
| I_{SM} | Pulsed source current | | | | 48 | A |
| t_{rr} | Reverse recovery time | $I_{SD} = 8\text{A}, V_{GS} = 0\text{V}, dI/dt = 100\text{A}/\mu\text{s}$ | | 319 | | ns |
| Q_{rr} | Reverse recovery charge | | | 4.4 | | μC |

Note: 1. Pulse test: Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

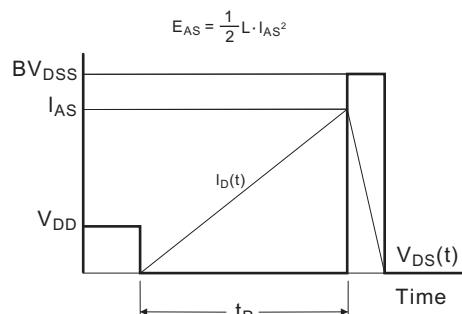
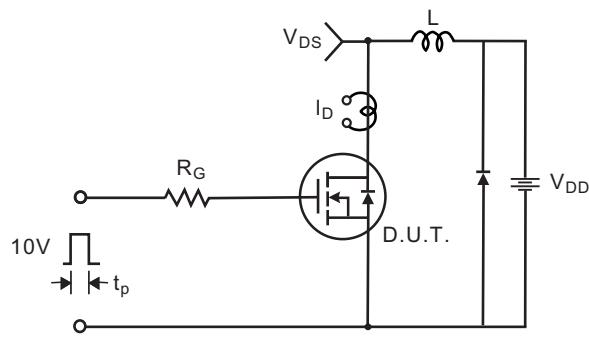
2. Essentially independent of operating temperature.

ORDERING INFORMATION SCHEME

■ Gate charge test circuit & waveform


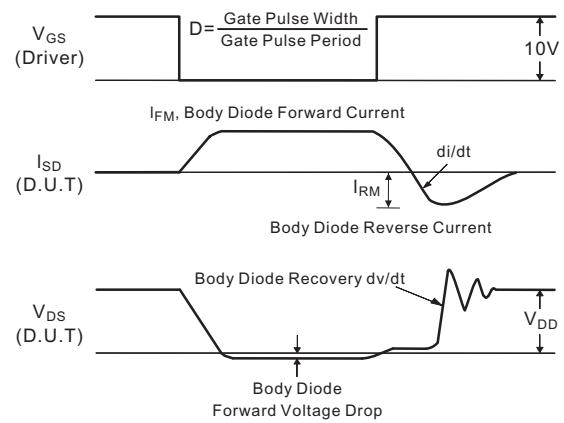
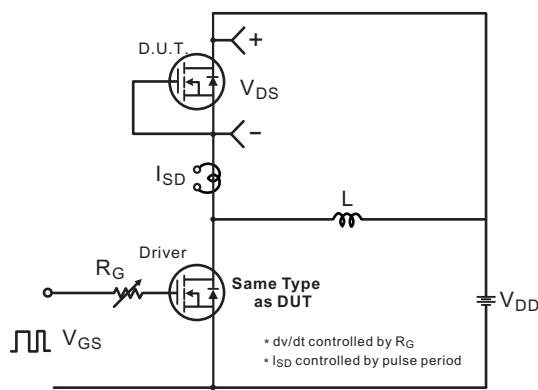
■ RESISTIVE SWITCHING TEST CIRCUIT & WAVEFORM



■ UNCLAMPED INDUCTIVE SWITCHING TEST CIRCUIT & WAVEFORMS



■ PEAK DIODE RECOVERY dv/dt TEST CIRCUIT & WAVEFORMS



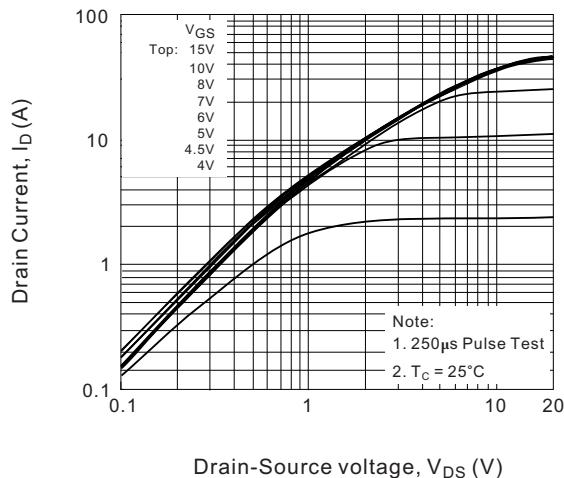
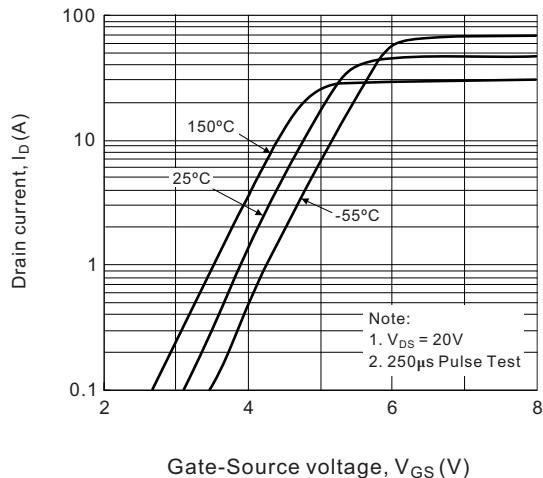
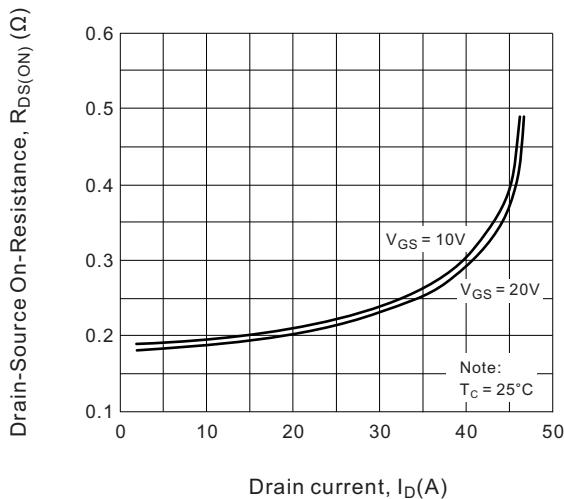
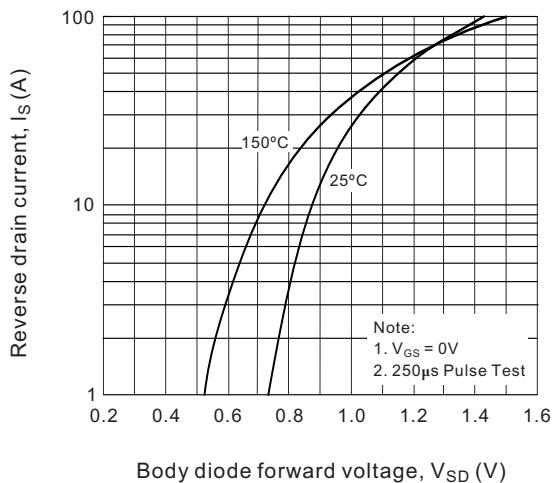
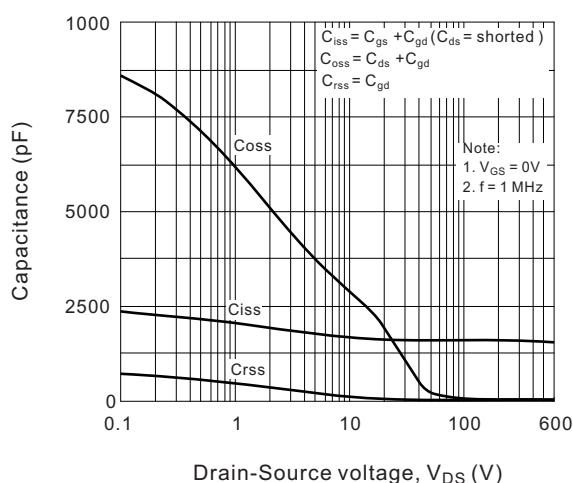
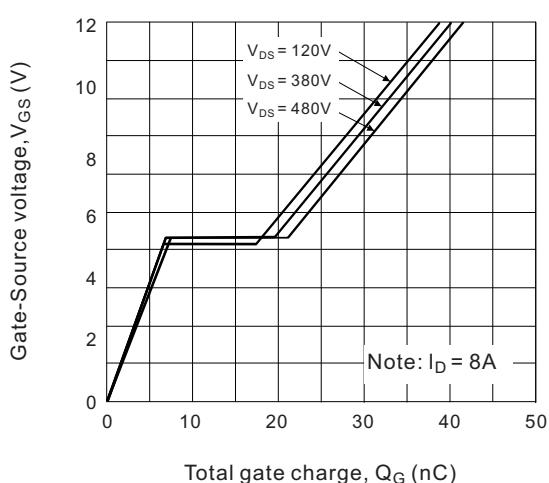
■ TYPICAL CHARACTERISTICS
Fig.1 On-State characteristics

Fig.2 Transfer characteristics

Fig.3 On-Resistance variation vs. drain current and gate voltage

Fig.4 Body diode forward voltage variation vs. Source current and Temperature

Fig.5 Capacitance characteristics

Fig.6 Gate charge characteristics


Fig.7 Breakdown voltage variation vs. Temperature

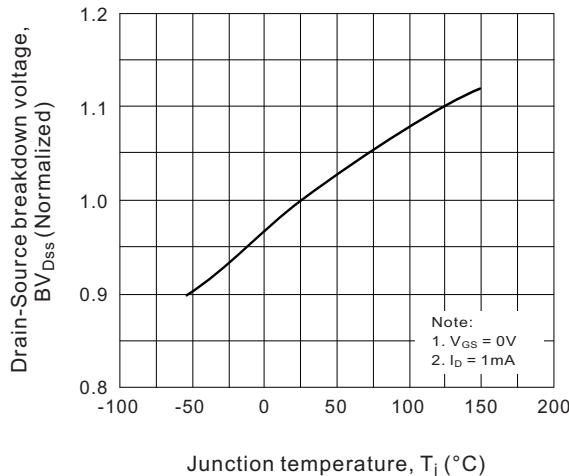


Fig.8 On-Resistance variation vs. Temperature

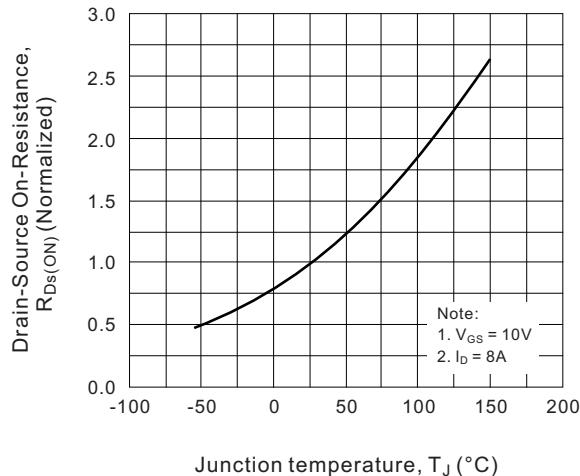


Fig.9 Maximum safe operating area (16N60A/16N60B)

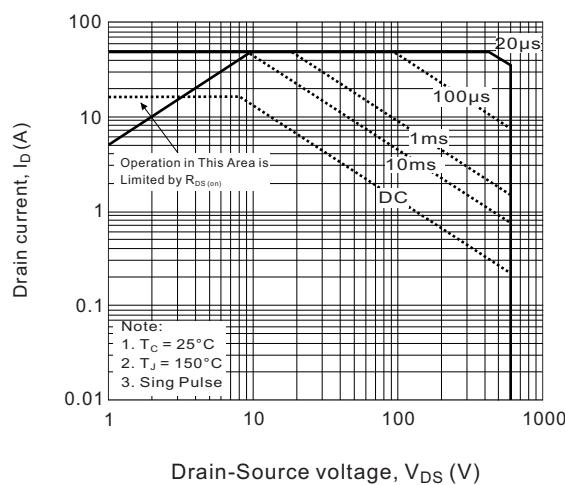


Fig.10 Maximum safe operating area (16N60AF)

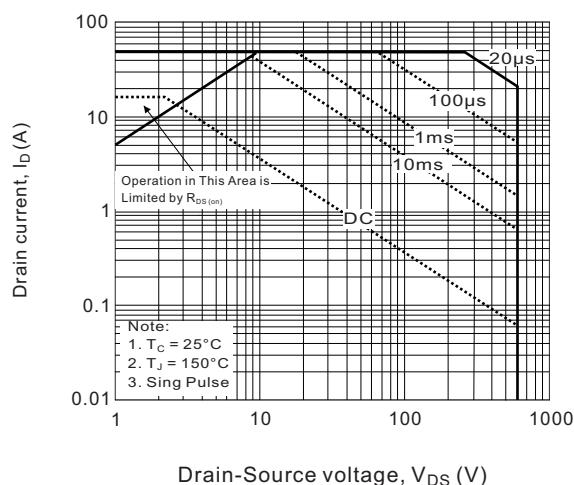
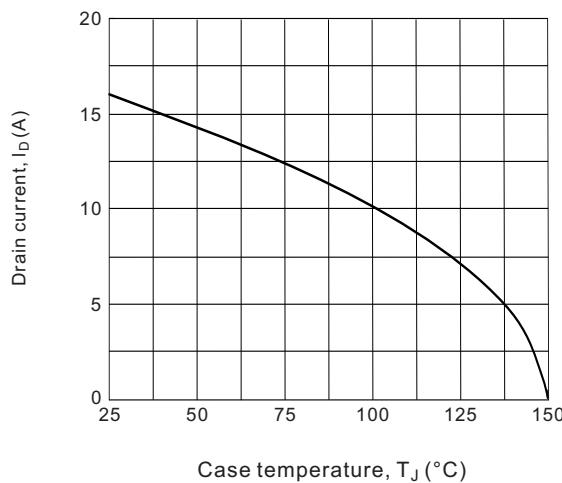
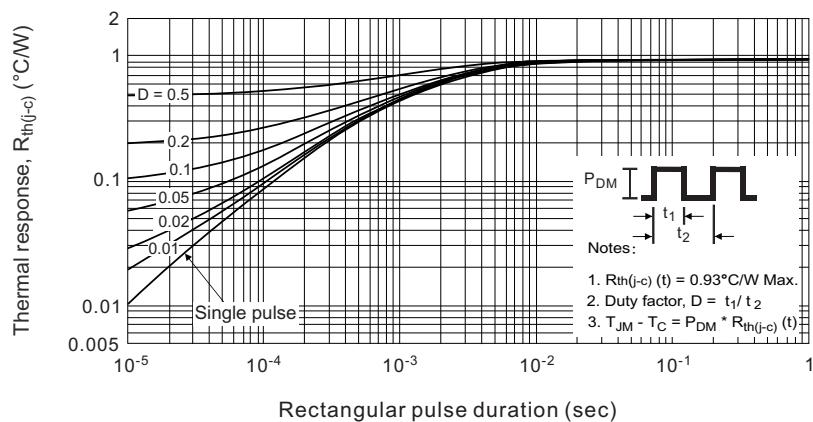


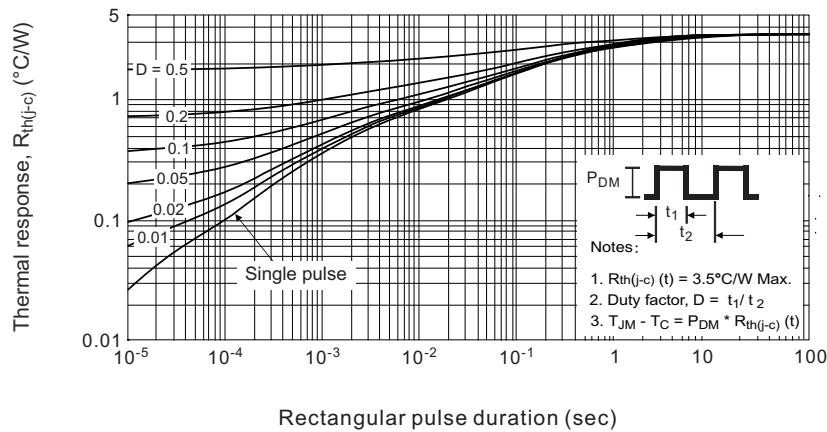
Fig.11 Maximum drain current vs. Case temperature



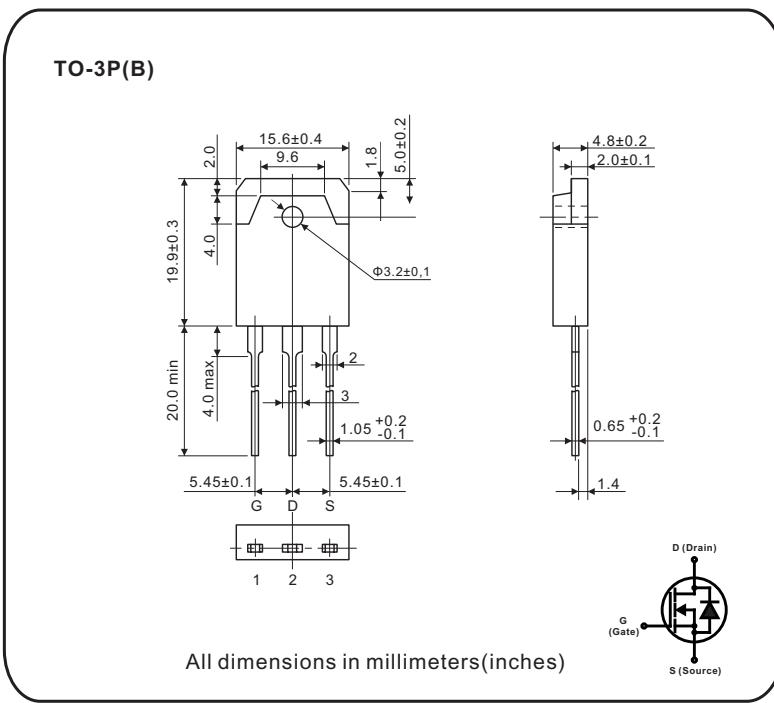
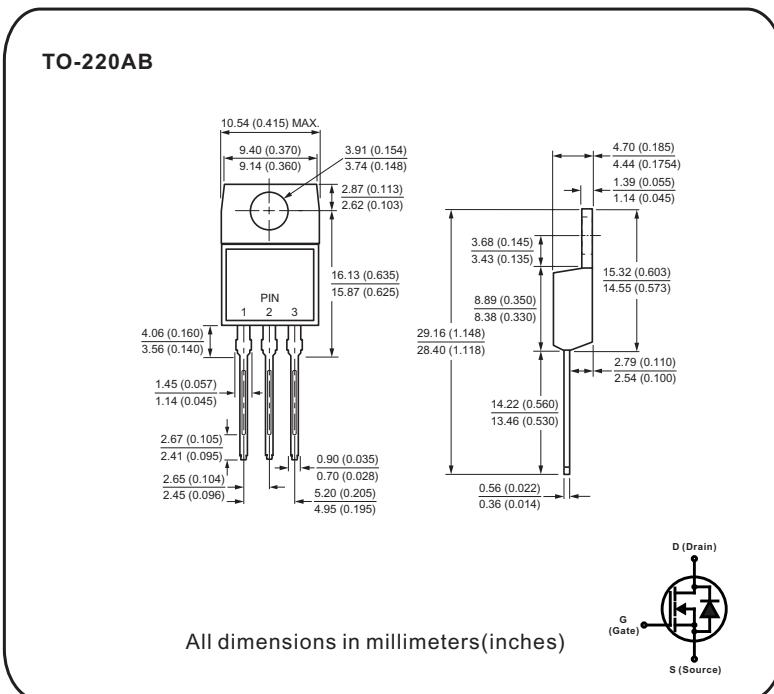
**Fig.11-1 Transient thermal response curve
for 16N60B & 16N60A**



**Fig.11-2 Transient thermal response curve
for 16N60AF**



Case Style



Case Style

